

#### PROF. SANKARAN.S

Department of Metallurgical and Materials Engineering

IIT Madras

**INTENDED AUDIENCE :** Undergraduate students of Metallurgical and Materials, Physics, Chemistry and biological sciences

**INDUSTRIES APPLICABLE TO :** All the Metallurgical and automotive industries will be interested in this

course

## COURSE OUTLINE :

It is the first course at the under graduate level on microstructural characterization of materials. This course will cover the basic principles and techniques of X-ray diffraction, optical, scanning electron and transmission electron microscopy along with demonstrations of the instrument details and imaging experiments through videos. This course also deals with the sample preparation techniques for the microstructural analysis with practical examples through videos.

## ABOUT INSTRUCTOR :

Prof. S.Sankaran is presently Associate Professor in the Department of Metallurgical and Materials Engineering, IIT Madras. His research interests are deformation processing of materials, mechanical behavior of materials and electron microscopy. He is also presently the faculty incharge of central electron microscopy of IIT Madras.

## COURSE PLAN :

## Week 1:

- 1. Fundamentals of optics
- 2. Optical microscope and its instrumental details

# Week 2:

- 3. Variants in the optical microscopes and image formation
- 4. Phase contrast, Polarised light, Differential interference contrast, Fluorescence microscopy **Week 3 :**
- 5. Sample preparation and applications of optical microscopes

#### Week 4 :

6. Introduction to Scanning electron microscopy (SEM)

#### Week 5 :

7. Instrumental details and image formation of SEM

# Week 6 :

- 8. Various imaging techniques and spectroscopy
- 9. Sample preparation and applications of SEM

# Week 7:

- 10. Fundamentals of X-ray scattering
- 11. Bragg's law derivation and the factors affecting the intensity

# Week 8 :

- 12. Crystallite size, effect of strain on the intensity
- 13. Profile fit, indexing, peak broadening

# Week 9:

14. Quantitative analysis, residual stress analysis

15. Instrumentation details and demo experiments of XRD

# Week 10 :

16. Introduction to transmission electron microscopy (TEM) Week 11 :

- 17. Diffraction and image formation
- 18. Various imaging techniques and spectroscopy

# Week 12 :

19. Sample preparation and applications of TEM

20. Instrumentation details and demo experiments of TEM